

## An Unexpected Application of Fairness to Higgs Boson Detection

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## Higgs decay to Muons



- ▶ Yukawa coupling  $\propto$  fermion mass
- ▶ Fermion masses are free parameters of SM and have to be determined experimentally
- $\blacktriangleright$  Coupling to muon  $(\mu)$  not observed
- ▶ ATLAS and CMS found evidence
- ▶ Simulated ATLAS Run 2 data

$$
\blacktriangleright \sqrt{s} = 13 \text{ TeV}, \ \mathcal{L} = 139 \text{ fb}^{-1}
$$





### $\mu\mu$  Production



#### $\overline{\mu\mu}$  Production



### Outline Analysis Strategy

B

- $\triangleright$  Fit S+B-model to dimuon mass  $M_{\mu\mu}$  spectrum
- ▶ Significance  $= S/\Delta$
- ▶ Uncertainties:

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- $\triangleright$  Statistical  $\Delta_{\text{stat}} = \sqrt{\frac{1}{n}}$ ▶ Systematic  $\Delta_{\text{syst}}$
- ▶ Machine Learning (ML)





### Enrich S/B with Machine Learning

- ▶ Train ML model using detector observables
- ▶ Boosted Decision Tree (BDT)
- ▶ Categorise by BDT score
- ▶ Extract S and B in each category
- $\blacktriangleright$  Maximise the total significance





### Mass Sculpting

- ▶ Perform fit to  $M_{\mu\mu}$  spectrum of each category
- $\blacktriangleright$  Classifier can change  $M_{\mu\mu}$ spectrum
- $\blacktriangleright$  Fit too much S
- ▶ Mass sculpting can cause  $\Delta_{\text{syst}}$
- $\blacktriangleright$  Run 2 Legacy (R2L): trained on events with  $M_{uu} \in [120, 130]$  GeV



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### Fairness in Particle Physics

- $\triangleright$  Use fairness to reduce  $\Delta_{\text{syst}}$
- ▶ Same shape  $M_{\mu\mu}$  distribution of B events for each category
- $\triangleright$  Equal Opportunity for B (EOP<sub>B</sub>)

**Fairness** 





- ▶ Example from: Hardt, Price, Srebro, 2016 <https://arxiv.org/pdf/1610.02413.pdf>
- ML and bank loans
- $\triangleright$  Black people got rejected the **most** given they never defaulted on a loan Asian people got rejected the **least** given they never defaulted on a loan
- $\triangleright$  They did not have EOP of getting the loan



▶ Equal Odds (EOD) is when EOP is satisfied for both classes:

$$
P\Big(R(x)\in [r_1,r_2]|M_{\mu\mu},y\Big)=P\Big(M_{\mu\mu},y\Big)
$$

- ▶ Stronger than EOP
- ▶ It turns out that in the case of  $H \rightarrow \mu\mu$ : EOP<sub>S</sub> always satisfied
- ▶ In the case of  $H \rightarrow \mu\mu$ : EOD = EOP<sub>B</sub>



▶ Strategy from the literature: Post Integration (PI)

- $\blacktriangleright$  Train classifier R with  $M_{\mu\mu}$  as input
- $\blacktriangleright$  Integrate out  $M_{\mu\mu}$ :

$$
R_{\rm Pl}(x)=\int_{110}^{160}R(M_{\mu\mu},x)P(M_{\mu\mu})dM_{\mu\mu}
$$

- $\blacktriangleright$  Effective, but can decrease performance a lot. Therefore used in combination with  $R2L (R2L+PI)$
- $\triangleright$  It is applied after training, therefore the actual ML trained classifier is not fair

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### ROC-Split

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- ▶ Given a threshold  $t: R(x) \geq t$  is classified as S and  $R(x) < t$  as B
- $\blacktriangleright$  True positive rate (tpr) is the chance of correctly classifying S
- $\blacktriangleright$  False positive rate (fpr) is the chance of falsely classifying B as S

\n- Receiver Operator Characteristic (ROC):
\n- $$
ROC(t) = (fpr(t), \text{tpr}(t))
$$
\n

▶ Area Under the Curve (AUC)



### EOD and ROC-curves

- ▶ EOD is satisfied when the ROC-curve is independent of  $M_{\mu\mu}$
- $\triangleright$  When EOP<sub>S</sub> is satisfied:  $EOD = EOP_B$

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 $\triangleright$  Consequence: EOP<sub>B</sub> is satisfied when  $EOP<sub>S</sub>$  is satisfied and the path of the ROC-curve is independent of  $M_{\mu\mu}$ 



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 $\blacktriangleright$  Algorithm to train classifiers satisfying EOP:

- 1. Divide  $M_{uu}$  up in bins and determine  $\{AUC_i\}$
- 2. Sample from a bin with  $p_i = 2(1 \text{AUC}_i)$
- 3. Train model on this new set and repeat
- $\triangleright$  Can be applied to ML architectures using epochs
- ▶ Flexibility: choice between fairness and performance



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### Results



- $\blacktriangleright$  Similar significance for the three methods
- $\triangleright$   $\Delta_{\text{stat}}$  >>  $\Delta_{\text{svst}}$
- ▶ Impact of fairness limited for this analysis with the current available data



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### Conclusion & Outlook



- ▶ Two new methods for reducing ML bias for  $H \to \mu\mu$ :
	- 1. ROC-Split
	- $2. R2L + Pl$
- ▶ Both similar significance as R2L
- ▶ ∆stat >> ∆syst
- ► Reduction of  $\Delta_{syst}$  becomes more important as more data becomes available
- ▶ Create a measure to quantify ML biases
- $\triangleright$  Construct a general decorrelation strategy with fairness



## Thank you!







#### Event selection

#### Channel Name | Event Selection



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### Input observables





- ▶ Fit S+B-model to  $M_{\mu\mu}$  spectrum
- $\blacktriangleright$  S: Gaussian-like
- $\blacktriangleright$  Theoretical core function: Breit-Wigner(BW) or Drell-Yan (DY)
- Empirical function  $\mathcal{F}_{\mathcal{E}}$
- $\blacktriangleright$  B-function: core function  $\times \mathcal{F}_{\mathcal{E}}$





- $\triangleright$  S: double-sided Cristal Ball  $(CB)$
- $\blacktriangleright$  Fit on simulated data
- ▶ Each category separately
- $\triangleright$  Shape of S fixed in S+B-model

$$
\textit{CB} = \begin{cases} e^{-\frac{1}{2}t^2} & \textit{for } -\alpha_{\textsf{left}} \leq t \leq \alpha_{\textsf{right}} \\ e^{-\frac{1}{2}\alpha_{\textsf{left}}^2\left[\frac{\alpha_{\textsf{left}}}{n_{\textsf{left}}}\left(\frac{n_{\textsf{left}}}{\alpha_{\textsf{left}}}-\alpha_{\textsf{left}}-t\right)\right]^{-n_{\textsf{left}}}\right.\right.\right.\right.} & \textit{for } t < -\alpha_{\textsf{left}} \\ e^{-\frac{1}{2}\alpha_{\textsf{right}}^2\left[\frac{\alpha_{\textsf{right}}}{n_{\textsf{right}}}\left(\frac{n_{\textsf{right}}}{\alpha_{\textsf{right}}}\left.\alpha_{\textsf{right}}+t)\right]^{-n_{\textsf{right}}} & \textit{for } t > \alpha_{\textsf{right}}, \end{cases}
$$

### Background functions

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$$
BW = \frac{1}{(M_{\mu\mu} - m_Z)^2 + \frac{\Gamma_Z^2}{4}}
$$

$$
DY = \frac{k}{(M_{\mu\mu}^2 - m_Z^2)^2 + m_Z^2 \Gamma_Z^2}
$$

$$
\mathcal{F}_{\mathcal{E}} = \begin{cases}\n\text{PowerN} &= M_{\mu\mu}^{a_0 + \dots + a_{N-1} M_{\mu\mu}^{N-1}} \\
\text{EpolyN} &= e^{a_1 M_{\mu\mu} + \dots + a_N M_{\mu\mu}^N} \\
\text{PolyN} &= a_1 M_{\mu\mu} + \dots + a_N M_{\mu\mu}^N\n\end{cases}
$$

Nik hef Bias Studies

- Signal strength:  $\mu = \frac{S}{S_0}$  $\mathcal{S}_{\mathsf{SM}}$
- $\blacktriangleright$  Fit S+B-model on 2000 toy sets
- $\blacktriangleright$  Pull =  $\frac{\mu_{\text{truth}} \mu_{\text{fit}}}{\sigma_{\text{fit}}}$
- $\blacktriangleright$  Mean pull is spurious signal uncertainty  $\Delta_{ss}$



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#### **Significance**



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- ▶ High Luminosity LHC
- ▶ Extrapolated dataset to  $\mathcal{L} = 3000$  fb<sup>-1</sup>
- $\triangleright$   $\Delta_{\text{stat}} < \Delta_{\text{ss}}$

